Search Notes



Ap	plica	tion	Contr	ol No.
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Examiner

Matthew G. Kayrish

Applicant(s)/Patent under Reexamination

IMAI, FUMIHITO

Art Unit

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	SEARCHED					
Class	Subclass	Date	Examiner			
360	133 ·	4/17/2006	мк			
360	131	4/17/2006	MK			
360	132	4/17/2006	MK			
360	135	4/17/2006	MK			

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
EAST (USPG-PUB, USPAT, USOCR) (See Attached Search History)	4/17/2006	MK